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Lattice-polarity-driven epitaxy of hexagonal semiconductor nanowires

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ABSTRACT: Lattice-polarity-driven epitaxy of hexagonal semiconductor nanowires (NWs) is demonstrated on InN NWs. In-polarity InN NWs form typical hexagonal structure with pyramidal growth front, whereas N-polarity InN NWs slowly turn to the shape of hexagonal

pyramid and then convert to an inverted pyramid growth, forming diagonal pyramids with flat surfaces and finally coalescence with each other. This contrary growth behavior driven by lattice-polarity is most likely due to the relatively lower growth rate of the $(000\bar{1})$ plane, which results from the fact that the diffusion barriers of In and N adatoms on the (0001) plane (0.18 and 1.0 eV, respectively) are about two-fold larger in magnitude than those on the $(000\bar{1})$ plane (0.07 and 0.52 eV), as calculated by first-principles density functional theory (DFT). The formation of diagonal pyramids for the N-polarity hexagonal NWs affords a novel way to locate quantum dot in the kink position, suggesting a new recipe for the fabrication of dot-based devices.

Semiconductor nanowires (NWs), such as GaN, ZnO, CdS, InAs, etc, have attracted much attention during the past years due to their nearly perfect crystalline quality and a wide range of applications including highly efficient, nanoscale optoelectronic and electronic devices.¹⁻⁵ To achieve such high quality semiconductor NWs, one-dimensional (1D) growth is essential. Most of the semiconductor NWs, such as GaN, ZnO and CdS with well-manipulated 1D growth, are in hexagonal phase in which the NWs easily grow along c-direction. The shape and diameter of such NWs are therefore well-controlled. Recently, a lattice-polarity effect was observed in some NWs, due to the partial ionicity of the chemical bonds, which may lead to different growth behaviors of these nanowires and the final orientation to be different.⁶⁻¹⁰ Based on this polarity effect, new nanostructures such as kinks and tripods have been reported, especially in the transition region between cubic and hexagonal phases.¹¹⁻¹³ Even though these findings are exciting, the mechanism underlying the formation of these different structures and their correlation with the polarity effect remain unclear. Moreover, most of these structures are based on GaN or II-VI semiconductors (ZnO, ZnS, CdS, etc) with relatively large bandgaps and low electron mobility,^{1,3,5} which limits their application in solar-related, ultrafast electronic, and other

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3 optoelectronic devices. Similar structures in semiconductors with small bandgaps and high
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5 electron mobility, ideally InN, are highly desired.¹⁴
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8 In spite of the seemingly clear desire for the growth of polarity-induced InN nanowires,
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10 reports on such studies are rare, mainly due to fact that the low maximum growth temperature
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12 and the lack of suitable substrate.¹⁵ InN is a member of III-nitrides with a narrow direct band gap
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14 of 0.64 eV at room temperature, high electron mobility ($4400 \text{ cm}^2/\text{Vs}$ at 300 K), small effective
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16 mass ($0.07 m_0$), and high saturation velocity ($2.5 \times 10^{17} \text{ cm/s}$).¹⁴⁻¹⁸ InN NWs have thus emerged as
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18 an excellent candidate for several nanoscale optoelectronic applications, such as nano-LEDs,^{19,20}
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20 nano-lasers,^{1,21} nano-solar cells,²² nano-biochemistry sensors,²³ and single photon emitters,²⁴⁻²⁶
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22 etc. In addition, the tunable bandgap energy of InGaN (0.64-3.43 eV) matches perfectly with the
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24 solar spectrum. Because of a recently discovered light-concentrating property of standing
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26 nanowires,^{27,28} InGaN provides a promising approach to enhancing the efficiency of nano-solar
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28 cells. Here, we explore the lattice-polarity-driven epitaxy mechanism using InN.
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34 Our experiments clearly reveal that lattice-polarity extensively influences the growth behavior
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36 of InN NWs, as was reported earlier for GaN and II-VI semiconductors. Besides this and more
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38 interestingly, the InN NWs exhibit completely different features in a well-controlled manner
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40 from the ones reported. In-polarity NWs form typical hexagonal structure with pyramidal growth
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42 front, whereas the N-polarity NWs slowly turn to the shape of hexagonal pyramid and then
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44 convert into inverted pyramid growth, forming diagonal pyramids with flat surfaces, which
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46 finally coalesce with each other. A quantum dot can easily form at the kink position. This
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48 contrary growth behavior can be rationalized using kinetic Wulff's plot combined with first-
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50 principles density functional theory. Since the kink position is well-connected with the structures
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52 on both sides, especially with the diagonal pyramids with flat surfaces on the top, fabrication of
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3 devices becomes convenient. The structure we observed thus suggests a new recipe for the
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5 fabrication of dot-based devices, which could be applicable to a wide range of nanoscale
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7 optoelectronic and solar systems.
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10 An observation of an unusual nanowire, as shown in [Figure 1](#), led us to be interested in the
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12 lattice-polarity-driven epitaxy of InN NWs. These InN NWs were grown by SVTA radio-
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14 frequency plasma-assisted molecular beam epitaxy (RF PA-MBE) on pillar-patterned GaN
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16 templates, which were fabricated by nanoimprint technology, without using any foreign mask or
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18 catalyst. N-rich growth conditions were maintained with a nitrogen flow rate of ~ 1.2 standard
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20 cubic centimeters per minute (sccm), RF plasma forward power of 400 W, and In beam flux of
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22 $\sim 2.0 \times 10^{-7}$ Torr. The corresponding V/III ratio was about 5. Most of the InN NWs exhibited
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24 regular shape with hexagonal pyramidal front, with nearly uniform diameter of ~ 400 nm and six
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26 smooth sidewalls. This morphology is similar to other hexagonal semiconductor NWs, such as
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28 GaN, CdS, and ZnO.^{1,3,7,29} The most interesting observation is that a few nanowires ending with
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30 very big, inverted pyramid-shaped, hexagonal cap with diameter of $3 \mu\text{m}$ co-existed with the
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32 much smaller wires as shown in [Figure 1a](#). The tilt-view scanning electron microscopy (SEM)
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34 image in [Figure 1b](#) shows that the InN NW changed its growth behavior at a kink position and
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36 then an inverted hexagonal pyramid with a flat top surface grew.
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43 To understand the mechanism behind, Titan-CsP probe-corrected scanning transmission
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45 electron microscopy (STEM) was performed on the sample and the corresponding TEM images
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47 are shown in [Figure 2a](#). Although the inverted pyramid was slightly separated from the bottom
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49 wire during the focus ion beam (FIB) preparation of the TEM specimen, GaN pillars at bottom
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51 and InN wires can clearly be distinguished. High resolution STEM was performed at different
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53 positions (marked in [Figure 2a](#) as b, c and d), which corresponded to the GaN pillar, InN wire
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and InN inverted pyramid, respectively. Corresponding annular bright field (ABF) STEM images at atomic level are shown in Figure 2b, 2c and 2d. In the ABF-STEM images, the darkest spots correspond to the heaviest atoms.³⁰ As such, we are able to configure the atomic structure, which is shown in the ABF-STEM images in which the blue and red balls represent the Ga and In atoms, respectively, while the gray ones indicate the N atoms. By comparing the experimental atomic structures with the schematic ones shown in Figure 2e, we determined that the lattice-polarity of the GaN pillar, InN wire and inverted pyramid is Ga-, In- and N-polarity, respectively. In addition, we also measured other InN NWs that have the conventional shape without the inverted pyramid and the STEM results showed that they are all In-polarity. Furthermore, the lattice-polarity was actually also confirmed by chemical wet etching, which showed the same result as the STEM measurement (data not shown here).

Based on above results, the lattice-polarity seems to be the origin for the formation of the inverted InN pyramid. To further clarify and demonstrate this point, systematical study on the lattice-polarity-driven growth of InN NWs has been performed on pillar-patterned GaN templates with different polarities. The growth conditions for In- and N-polarity InN NWs were the same except that the N-polar NWs were grown at 600 °C, which was about 100 °C higher than that of In-polarity NWs. The lattice-polarity of the InN NWs was controlled by the pillar-patterned GaN templates; in other words, the Ga(N)-polar pillar leads to In(N)-polarity NWs. The entire growth procedure was monitored in situ by reflection high energy electron diffraction (RHEED) and the RHEED patterns at different stages are shown in Figure 3. Before the deposition of InN, streaky patterns along the $[11\bar{2}0]$ and $[1\bar{1}00]$ azimuths are clearly observed, as shown in Figure 3 (0 min), indicating that the surfaces for Ga- and N-polarity pillar-patterned GaN templates were flat. Thereafter, the changes in the RHEED patterns over time differ with

opposite lattice polarities. The most obvious feature is that along with the growth time, the RHEED pattern of the In-polarity InN NWs remains spotty, whereas for the N-polarity NWs, the pattern changes from spotty to streaky, suggesting quite different growth behaviors.

In the case of In-polarity, the RHEED pattern along the $[11\bar{2}0]$ azimuth gradually changes from streaky to slightly spotty with weakly forked tails (as shown in Figure 3a (10 min)) at the initial growth stage, indicating that the surface becomes rough. The pattern then becomes brightly spotty with well-defined crossed-chevrons that barely budged in the following process (Figure 3a (30 min)). However, the RHEED pattern along the $[1\bar{1}00]$ azimuth remains mostly unchanged, with the chevrons observed during the full process. The observation of the off-normal streaks being elongated from the center spot pattern indicates that the top surface has a faceted structure.^{31,32} As such, it is not surprising that chevron patterns indicate that the NWs have a pyramid-shaped top surface. The interesting feature is that the chevrons along the $[11\bar{2}0]$ azimuth form an included angle of 64° (Figure 3a (30 min)), which indicates that the top facets of the NWs are of the $\{1\bar{1}03\}$ family. This is similar to Ga-polarity GaN NWs that have a pyramidal top with $\{1\bar{1}0n\}$ planes.^{33,34}

In the case of N-polarity, as shown in Figure 3c and 3d, the RHEED patterns gradually change from streaky to chevrons with a center streaky line, indicating that the NWs have faceted sidewalls with flat top surface. Then, the patterns return to being streaky and remain so until the end of the growth, suggesting a top flat surface with no sidewall. This novel observation is unexpected, since it suggests that the tilted top facets were gradually annihilated and merged together. Such an observation has not been previously reported and is quite difficult to understand at such extremely N-rich growth condition for nanowires.

Above interpretation of the RHEED patterns is supported by the direct observations of the morphology of NWs, as shown in Figure 4. The In-polar InN NWs exhibit regular shape with hexagonal pyramid-shaped front, nearly uniform diameter and six smooth sidewalls (Figure 4a). This morphology appear to be almost the same as previously reported hexagonal wires and sidewalls of $\{1\bar{1}00\}$ m-faces.^{17,20,22,25,33} It is quite interesting that the N-polar InN NWs become narrower and narrower to form a kink and suddenly begin to broaden (Figure 4b). Finally, the NWs coalesce with each other and form a flat surface, with an inverted pyramid shape from the kink, which is the same as that shown in Figure 1. The top-view SEM image in the inset also clearly shows the aggregation of the NWs.

To further explicate the growth behaviors of InN NWs, we present in Figure 5a a schematic of the process with four growth stages corresponding to the RHEED patterns shown in Figure 3. Meanwhile, the growth process of opposite polarities nanowires also divided into four stages (Figure 5b and 5c), which tally well with the schematic model.

It is easy to understand that the growth mechanism of In-polar NWs is almost the same as that of hexagonal semiconductor wires such as ZnO, CdS, and GaN.^{7,35,36} However, the growth behaviors of N-polar InN NWs are difficult to understand, particularly the inverted pyramid growth. It is possible to understand that the top face of the N-polar NWs almost always keep flat whereas the In-polar ones keep needle-like. This is most likely due to the anisotropic growth velocities along different orientations, which can be described by the kinetic Wulff's plots (v-plot).^{36,37,38} Given the features of In- and N-polar InN NWs, it is convenient to deduce the relative growth-rate ratios of the (0001), $(1\bar{1}03)$, $(1\bar{1}00)$, and $(000\bar{1})$ planes to be 5.3:1.2:1.8:1 based on the data in Figures 5b and 5c, which are the key points of the v-plot. (These growth rates ratios are not unique, but change with the growth conditions, including the growth

temperature and the V/III ratio.) To complete the v -plot, the growth rates between these special orientations were extrapolated as long as they did not modify the shape of the v -plot.^{36,39} The calculated schematic v -plot of InN is shown in Figure 6a. It is shown that the growth rate of the InN (0001) plane is significantly larger than that of the (000 $\bar{1}$) plane, and thus we are able to predict that the In-polar NWs have a pyramid growth front with {1 $\bar{1}$ 0n} planes while the N-polar NWs keep flat top, as schematized in the bottom of Figure 6a.

To understand the physics behind the difference in growth rates, a detailed analysis of the diffusion barriers of In and N adatoms on InN surfaces have been performed by first-principles density functional theory calculations as implemented in the Vienna Ab-Initio Simulation Package (VASP). In the calculation, we used the Perdew-Burke-Ernzerhof (PBE) version of the generalized gradient approximation (GGA) and the projector-augmented wave method.^{40,41} A plane-wave cutoff energy of 550 eV was used and a 4×4×1 k-point mesh was set. To calculate the diffusion barriers on the thermodynamically stable sites, we used two kinds of atomic structures that both terminated with In atoms,^{42,43} as shown in Figure 6b. The (2×2) supercells used for the calculations contained six bilayers with a ~ 16 Å thick vacuum: the bottom three bilayers were fixed in the bulk configurations, but the upper three bilayers and the adatoms were allowed to relax. The diffusion barriers were calculated using the climbing image nudged elastic band (CI-NEB) method^{44,45} in which all the force components that were perpendicular to the tangent of the reaction pathway were reduced to be less than 0.05 eV/Å. As shown in Figure 6c, the diffusion barriers of In and N adatoms on the (0001) plane (i.e., In-polarity) are 0.18 eV and 1.00 eV, respectively, which are about 2-fold in magnitude larger than 0.07 eV and 0.52 eV on the (000 $\bar{1}$) plane (i.e., N-polarity).

It is well known that the diffusion length of adatoms is proportional to $\exp[-E_A/(2k_B T)]$, where E_A , k_B , T are the diffusion barrier, Boltzmann constant, and growth temperature, respectively.⁴⁶ Therefore, the diffusion lengths of In and N adatoms on the (000 $\bar{1}$) plane are larger than those on the (0001) plane. The former is probably even much larger than the estimated one, since the growth temperature of N-polar InN NWs was 100 °C higher than that of the In-polar InN NWs.⁴⁷ This difference is probably the essential factor in the anisotropic growth velocity, as shown in Figure 6a. Compared with the In-polarity case, the relatively large diffusion lengths in the N-polarity case make it possible for adatoms to migrate to steps, kinks, and vacancies that are propitious to maintaining two-dimensional (2D) growth and that result in a lower growth rate under the same growth conditions.

Based on the v-plot and calculation results, we propose a lattice-polarity-driven growth mechanism to explain the intriguing phenomenon observed in InN NWs. At the initial stage, both In- and N-polar InN NWs show 3D growth, which is an inevitable product of N-rich growth conditions and the release of stress that results from the 10.8% lattice mismatch between InN and GaN.⁴⁸

I. In-polar InN NWs: The primary 3D growth and the large growth rate of the (0001) plane cause the c-plane to be rapidly annihilated to form a pyramid-shaped growth front that is surrounded by facets with relatively low growth rates, i.e., $\{1\bar{1}00\}$ and $\{1\bar{1}0n\}$ (in our case $n=3$) planes. This stabilized shape will be maintained in the subsequent growth process except that the diameter is slightly broadened due to the lateral growth as shown in Figure 5b (at 60, 90, and 150 min).

II. N-polar InN NWs: The incipient 3D growth causes the nanowires to exhibit a prismoid shape with a flat top as illustrated in Figure 5c (10 min), which results from the lowest growth

rate of the $(000\bar{1})$ plane. In this process, the prismoid shape gradually shrinks until the full relaxation of the lattice strain and then converts into a conical or near-conical (with a small flat top) shape, as shown in Figure 5c (30 min). However, according to the v-plot, InN nanostructures should be surrounded by facets with low growth rates for N-polarity, i.e., the $(000\bar{1})$ and $\{1\bar{1}00\}$ planes. Obviously, the conical or near-conical shape is not stable. Finally, the $(000\bar{1})$ plane appears again and expands gradually. With expansion of the $(000\bar{1})$ plane, more In atoms are directly adsorbed on the top rather than on the bottom or diffused to other nanowires, leading to stronger lateral growth and diagonal pyramids (Figure 5c (50 min)). That is also the reason for the lack of $\{1\bar{1}00\}$ planes, which is not contrary to the kinetic Wulff's plot.

From the above analysis, there is no doubt that the N-polarity leads InN NWs to experience inverted-pyramid growth, which explains our observations in Figure 1. Although it is extremely difficult to show the precise atomic structure of the inversion point for lattice polarity, which is too narrow and exhibits too much strain to be analyzed in TEM measurements, we can still reasonably assume that inversion of the lattice-polarity at the kink is most likely due to the formation of stacking faults, which are often observed in such NWs.^{11,33,49} Once the lattice polarity converts from In- to N-polarity, it will lead to inverted pyramid growth since the bottom In-polar NWs are almost free from strain.

Interestingly, the lattice-polarity-driven growth behavior reported here for InN NWs is not limited to InN itself. It should be applicable to other hexagonal semiconductor nanowires, such as GaN, ZnO, CdS and so on.

In conclusion, we have confirmed that opposite lattice polarity leads to different growth behaviors in InN NWs. Elongated NWs with typical pyramid-shaped growth fronts were observed for In-polarity. On the other hand, a hexagonal pyramid was gradually formed for the

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3 N-polarity NWs, which was followed by inverted pyramid-shaped growth, forming diagonal
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5 pyramids. The inverted pyramids exhibit flat top surfaces and broadened diameters during
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7 growth and finally coalescence with each other. This lattice-polarity-driven growth behavior is
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9 most likely due to the fact that the diffusion barriers for In and N adatoms on the (0001) plane
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11 are about two-fold larger in magnitude than those on the (000 $\bar{1}$) plane, as predicted from DFT
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13 calculations, that result in anisotropic growth velocities. A semi-quantitative lattice-polarity-
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15 driven growth mechanism was proposed to explain the diametrically opposed growth behaviors.
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17 We suggest that the formation of diagonal pyramids for the N-polarity NWs may provide a novel
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19 way to locate quantum dot in the kink position and thus improve the fabrication of dot-based
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21 optoelectronic devices since they finally coalescence with each other.
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Figures

Figure 1. (a) Top-view and (b) tilt-view SEM images of the inverted pyramid that emerged in In-polarity InN NWs.

Figure 2. (a) TEM image of an inverted InN NW. (b), (c), and (d) are ABF-STEM images of the zones marked as brown square (GaN pillar), red square (InN wire), and green square (inverted pyramid) in (a), respectively. Ga (blue balls), In (red balls), and N (gray balls) atoms were

embedded in the ABF-STEM images to show the atomic stack order. (e) Atomic schematics of Ga-polarity GaN, In- and N-polarity InN.

Figure 3. Evolution of RHEED patterns of (a, b) In- and (c, d) N-polarity InN NWs along the $[11\bar{2}0]$ and $[1\bar{1}00]$ azimuths with growth time of $t=0, 5, 30$, and 60 min. The white dashed line in (a) shows an included angle of 64° that indicates a diffraction pattern from the InN $\{1\bar{1}03\}$ family.

Figure 4. Cross-section SEM images of (a) In-polarity and (b) N-polarity InN NWs. Insets are top-views of the corresponding nanowires. The gray frames show the outline of opposite polarities InN NWs with pyramid-shaped growth fronts and inverted growth fronts, respectively.

Figure 5. (a) A schematic model of different growth stages of InN NWs with opposite polarities. Tilt-view SEM images of (b) In- and (c) N-polarity InN NWs with growth time.

Figure 6. (a) The kinetic Wulff's plots for InN across the $(11\bar{2}0)$ plane: the blue, brown, green, and red arrows correspond to the (0001) , $\{1\bar{1}0n\}$, $\{1\bar{1}00\}$, and $(000\bar{1})$ planes, and solid line shows the extrapolated velocity values. (b) Atomic structures (top view and side view) for (0001) and $(000\bar{1})$ In terminated surfaces. The red line at the top left marks the diffusion pathway corresponding to (c). Three key adsorption sites, fcc, bridge, and hcp, are also marked in this figure. (c) Total energy for In and N adatoms on (0001) and $(000\bar{1})$ surfaces, which was calculated based on the atomic structure shown in (b). Zero energy corresponds to the energetically lowest adsorption site.

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Notes

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Figure 1. (a) Top-view and (b) tilt-view SEM images of the inverted pyramid that emerged in In-polarity InN NWs.

238x98mm (300 x 300 DPI)

Figure 2. (a) TEM image of an inverted InN NW. (b), (c), and (d) are ABF-STEM images of the zones marked as brown square (GaN pillar), red square (InN wire), and green square (inverted pyramid) in (a), respectively. Ga (blue balls), In (red balls), and N (gray balls) atoms were embedded in the ABF-STEM images to show the atomic stack order. (e) Atomic schematics of Ga-polarity GaN, In- and N-polarity InN. 249x119mm (300 x 300 DPI)

Figure 3. Evolution of RHEED patterns of (a, b) In- and (c, d) N-polarity InN NWs along the $[112\bar{0}]$ and $[11\bar{0}0]$ azimuths with growth time of $t=0, 5, 30$, and 60 min. The white dashed line in (a) shows an included angle of 64° that indicates a diffraction pattern from the InN $\{11\bar{0}3\}$ family.

247x180mm (300 x 300 DPI)

Figure 4. Cross-section SEM images of (a) In-polarity and (b) N-polarity InN NWs. Insets are top-views of the corresponding nanowires. The gray frames show the outline of opposite polarities InN NWs with pyramid-shaped growth fronts and inverted growth fronts, respectively.
238x102mm (300 x 300 DPI)

Figure 5. (a) A schematic model of different growth stages of InN NWs with opposite polarities. Tilt-view SEM images of (b) In- and (c) N-polarity InN NWs with growth time.
240x186mm (300 x 300 DPI)

Figure 6. (a) The kinetic Wulff's plots for InN across the $(112\bar{0})$ plane: the blue, brown, green, and red arrows correspond to the (0001) , $\{11\bar{0}n\}$, $\{11\bar{0}0\}$, and (0001^-) planes, and solid line shows the extrapolated velocity values. (b) Atomic structures (top view and side view) for (0001) and (0001^-) In terminated surfaces. The red line at the top left marks the diffusion pathway corresponding to (c). Three key adsorption sites, fcc, bridge, and hcp, are also marked in this figure. (c) Total energy for In and N adatoms on (0001) and (0001^-) surfaces, which was calculated based on the atomic structure shown in (b). Zero energy corresponds to the energetically lowest adsorption site.

90x29mm (300 x 300 DPI)